
<p>ISSUE CLASSIFICATION</p>					
<p>Class</p>					
<p>Subclass</p>					

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PATENT NUMBER

U.S. UTILITY PATENT APPLICATION

C.O.I.P.E.

PATENT DATE:

U.F.P.E.
SCANNED 1 M4 aaEd

7C 1061

APPLICATION NO. 09/960356	CONT/PRIOR F	CLASS 257	SUBCLASS 428 <i>2.14</i>	ART UNIT 2811	EXAMINER <i>MUWSOW</i>
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TS Takashi Inbe

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
Semiconductor device for detecting neutron, and method for the fabrication

FTO-2040
12/99

PREPARED AND APPROVED FOR ISSUE

ISSUING CLASSIFICATION

[illegible]

 TERMINAL DISCLAIMER	DRAWINGS			CLAIMS ALLOWED	
	Sheets Drwg	Figs. Drwg	Print Fig	Total Claims	Print Claim for O'G
<input type="checkbox"/> a) The term of this patent subsequent to this disclaimer (date) has been disclaimed.	(Assistant Examiner) (Date)			NOTICE OF ALLOWANCE MAILED	
<input type="checkbox"/> b) The term of this patent shall not extend beyond the expiration date of U.S. Patent No.	(Primary Examiner) (Date)			ISSUE FEE	
				Amount Due	Date Paid
<input type="checkbox"/> c) The terminal months of this patent have been disclaimed.	(Legal Instruments Examiner) (Date)			ISSUE BATCH NUMBER	

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